2SC4953

Silicon NPN triple diffusion planar type

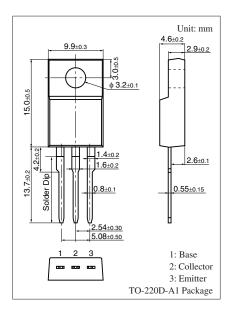
For high breakdown voltage high-speed switching

Features

- High-speed switching
- \bullet High collector-base voltage (Emitter open) V_{CBO}
- Wide safe operation area
- \bullet Satisfactory linearity of forward current transfer ratio h_{FE}
- Dielectric breakdown voltage of the package: > 5 kV

Absolute Maximum Ratings $T_a = 25^{\circ}C$

Parameter	Symbol	Rating	Unit	
Collector-base voltage (Er	V _{CBO}	500	V	
Collector-emitter voltage (E-B short)		V _{CES}	500	V
Collector-emitter voltage (Base open)		V _{CEO}	400	V
Emitter-base voltage (Collector open)		V _{EBO}	7	V
Base current		IB	1.2	А
Collector current	I _C	3	А	
Peak collector current		I _{CP}	6	А
Collector power	$T_C = 25^{\circ}C$	P _C	30	W
dissipation		2.0		
Junction temperature	Tj	150	°C	
Storage temperature	T _{stg}	-55 to +150	°C	

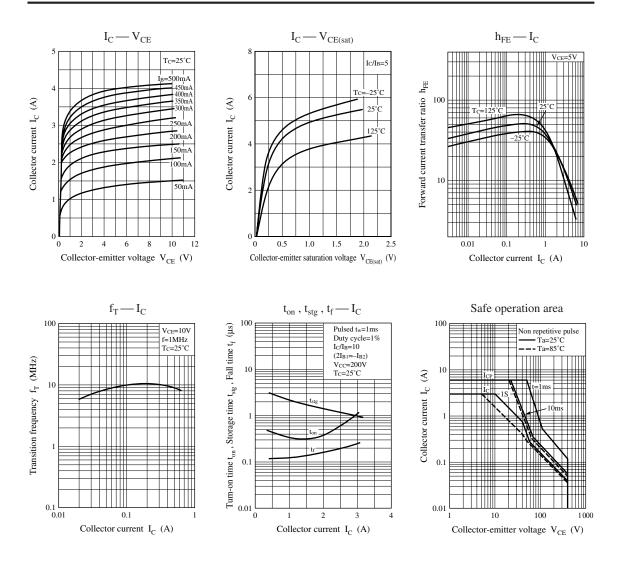


Electrical Characteristics $T_a = 25^{\circ}C \pm 3^{\circ}C$

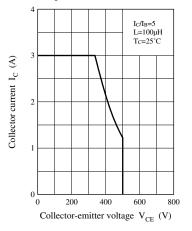
Parameter	Symbol	Conditions	Min	Тур	Max	Unit
Collector-emitter voltage (Base open)	V _{CEO}	$I_{C} = 10 \text{ mA}, I_{B} = 0$	400			V
Collector-base cutoff current (Emitter open)	I _{CBO}	$V_{CB} = 500 \text{ V}, I_E = 0$			100	μΑ
Emitter-base cutoff current (Collector open)	I _{EBO}	$V_{EB} = 5 V, I_C = 0$			100	μΑ
Forward current transfer ratio	h _{FE1}	$V_{CE} = 5 \text{ V}, I_C = 0.1 \text{ A}$	10			
	h _{FE2}	$V_{CE} = 2 V, I_C = 1.2 A$	8		40	
Collector-emitter saturation voltage	V _{CE(sat)}	$I_{\rm C} = 1.5 \text{ A}, I_{\rm B} = 0.3 \text{ A}$			1.0	V
Base-emitter saturation voltage	V _{BE(sat)}	$I_{\rm C} = 1.5 \text{ A}, I_{\rm B} = 0.3 \text{ A}$			1.5	V
Transition frequency	f _T	$V_{CE} = 10 \text{ V}, I_C = 0.2 \text{ A}, f = 1 \text{ MHz}$		10		MHz
Turn-on time	t _{on}	I _C = 1.5 A			1.0	μs
Storage time	t _{stg}	$I_{B1} = 0.15 \text{ A}, I_{B2} = -0.3 \text{ A}$			3.0	μs
Fall time	t _f	$V_{CC} = 200 V$			0.3	μs

Note) Measuring methods are based on JAPANESE INDUSTRIAL STANDARD JIS C 7030 measuring methods for transistors.

Panasonic



Safe operation area (Reverse bias)



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